D:Mang

Quantum Annealing With Superconducting Qubits

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Basic Circuit Elements



RF-SQUID



 $E = \frac{Q^2}{2C} + \frac{\Phi^2}{2L} - E_J \cos\phi$

RF-SQUID



Comparing RF-SQUID with a particle

	particle	SQUID
position	X	Φ
mass	т	C
momentum	$p = m\dot{x}$	$Q = C\dot{\Phi} = CV$
commutators	$[x, p] = i\hbar$	$[\Phi,Q] = i\hbar$
kinetic energy	$\frac{1}{2}m\dot{x}^2 = \frac{p^2}{2m}$	$\frac{1}{2}C\dot{\Phi}^2 = \frac{Q^2}{2C}$
Potential energy	$V(\Phi)$	V(x)

RF-SQUID Hamiltonian





RF-SQUID Hamiltonian







CJJ RF-SQUID Qubit



$$H = -\frac{1}{2} \left[\varepsilon \sigma_z + \Delta(\delta U) \sigma_x \right]$$

Control knobs: Φ_{1x} controls energy bias ε

 Φ_{2x} controls barrier height δU

Actual Qubit

Harris et al, arXiv:1004.1628 (2010)



Programmable Magnetic Memory (PMM)

Johnson et al., Supercond. Sci. Technol. 23, 065004 (2010)



Fabrication



Eight-Qubit Unit Cell

Qubit #1





128 Qubits Chip





Wire Bounded Chip





Pulse Tube Dilution Refrigerator





Annealing Process

Annealing happens by raising barrier height ΔU , which provides $\Gamma(t)$



At fixed external flux bias Φ_{1x} , raising barrier height will also changes the energy bias ϵ

Annealing in Our Hardware $H_P = \sum_{i=1}^N h_i \sigma_i^z + \sum_{i, j=1}^N J_{ij} \sigma_i^z \sigma_j^z$ $H = E(t) \left(H_P - \Gamma(t) \sum_{i=1}^N \sigma_i^x \right) \qquad \Gamma(t) = \frac{\Delta(t)}{2E(t)}$ Hamiltonian: 10e+4 5 E(t) [GHz] 10e+1 **1**0e-2 10e-5 1 0 10e-8 70 50 60 80 90 100 70 50 60 80 90 100 t [µs] t [µs] $\Gamma(t)$ changed from Γ_{max} to 0: Quantum annealing!

E(t) changes from 0 to E_{max} : Classical annealing!

Question:

Is it quantum or classical annealing?

Answer:

It depends on which one of quantum or thermal fluctuations are stronger

How can we determine this experimentally?

Macroscopic Quantum Tunneling

Current biased Josephson junction:





Measurements of Macroscopic Quantum Tunneling out of the Zero-Voltage State of a Current-Biased Josephson Junction

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(Received 26 July 1985)

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To express the experimental measurements of the escape rate in a way that is as independent as possible of the parameters of the junction, we introduce the "escape temperature" $T_{\rm esc}$ defined through the relation

$$\Gamma = (\omega_p/2\pi) \exp(-\Delta U/k_{\rm B}T_{\rm esc}).$$



(3)

FIG. 2. $T_{\rm esc}$ vs T for two values of critical current for $\ln(\omega_p/2\pi\Gamma) = 11$. The solid and open arrows indicate the predicted crossover temperatures for the higher and lower critical currents, respectively. The prediction of Eq. (5) for the higher critical current is indicated at the left.

Quantum Junction

Classical Annealing



 $\Gamma = (\omega_p / 2\pi) \exp(-\Delta U_{freeze} / k_B T) = \text{small number}$

Therefore: $\Delta U(t_{freeze}) = \Delta U_{freeze} \propto T$ If $\Delta U(t) \propto t$ then $t_{freeze} \propto T$ very similar to T_{esc}

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Quantum Annealing



Quantum mechanically tunneling amplitude exponentially depends on ΔU but not T

Therefore $\Gamma = T - indepdent$ or

 $t_{freeze} = T - independent$

h-Ramping Experiment



If $t_d < t_{freeze}$ then the final probability is: $P_0(h=h_0) > 0.5$

h-Ramping Experiment



If $t_d < t_{freeze}$ then the final probability is: $P_0(h=h_0) > 0.5$ If $t_d > t_{freeze}$ then the final probability is: $P_0(h=0) = 0.5$



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Quantum Simulations



Classical Simulations



Freeze-out Time

Classical prediction



Experiment vs. Simulations



All simulations are done with **no fitting parameter**

Experiment vs. Simulations



rf-SQUID behavior at different temperatures:

Up to 40 mK 2-level quantum system

Up to 80 mK 4-level quantum system

Above 100 mK Classical system

Can we do this for more than one qubit?



Hamiltonian:

$$\frac{H}{E(t)} = H_P - \Gamma(t) \sum_i \sigma_i^x$$
$$H_P = \sum_i^N h_i \sigma_i^z - J \sum_i^N \sigma_i^z$$

$$H_P = \sum_{i=1}^N h_i \sigma_i^z - J \sum_{i,j=1}^N \sigma_i^z \sigma_j^z$$









Is the ground state reached via classical or quantum annealing?

8-Qubit h-Ramping Experiment



8-Qubit h-Ramping Experiment



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8-Qubit h-Ramping Experiment



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8-Qubit Experimental Results



Saturation of the freeze-out time cannot be explained by classical physics

Modeling The System

Write down a Hamiltonian and solve it both

Classically:

Using Langevin equation

Quantum Mechanically:

Using density matrix approach

RF-SQUID Hamiltonian

Hamiltonian:

$$H_{\text{SQUID}} = \frac{q_1^2}{2C_1} + \frac{q_2^2}{2C_2} + U(\Phi_1, \Phi_2)$$



 $U(\Phi_1, \Phi_2) = (\Phi_1 - \Phi_{1x})^2 / 2L_1 + (\Phi_2 - \Phi_{2x})^2 / 2L_2$ $- 2E_J \cos(\pi \Phi_2 / \Phi_0) \cos(2\pi \Phi_1 / \Phi_0),$

Interaction with environment:

$$H_{\rm int} = -\frac{\Phi_1 - \Phi_{1x}}{L_1} \delta \Phi_{1x}$$

Noise spectral density:

$$S_{LF}(\omega) = \frac{(A^2/T)\omega|\omega|^{-\alpha}}{1 - e^{-\omega/T}} \approx A^2|\omega|^{-\alpha} \qquad S_{HF}(\omega) = \frac{\eta\omega e^{-|\omega|/\omega_c}}{1 - e^{-\omega/T}}$$

All parameters, including noise, are determined via independent experiments

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Extracting Noise Parameters

$$S_{LF}(\omega) = \frac{(A^2/T)\omega|\omega|^{-\alpha}}{1 - e^{-\omega/T}} \approx A^2|\omega|^{-\alpha} \qquad \qquad S_{HF}(\omega) = \frac{\eta\omega e^{-|\omega|/\omega_c}}{1 - e^{-\omega/T}}$$

A is determined from 1/f noise measurement

η is extracted from measuring the Macroscopic Resonant Tunneling (MRT)



Extracting Noise Parameters

$$\Gamma(\epsilon) = \frac{\Delta^2}{4} \int dt e^{i(\epsilon - \epsilon_p)t - W^2 t^2/2} \left[\frac{\pi T t}{(1 + i\omega_c t) \sinh \pi T t} \right]^{\frac{\eta}{2\pi}}$$





Fluctuation dissipation theorem: $\langle X(t)X(0)\rangle = \frac{2\gamma k_B T}{M}\delta(t)$

Classical Modeling

Each rf-SQUID potential has 2 space variables (x_1,x_2) and 2 velocities (v_1,v_2)



For 8 qubits, we solve Langevin equation on a **16 dimensional** potential

We run the program for more than 2000 times and find the probabilities statistically

We use distributed computation (AQUA@home): ~10,000 cores (>5500 computers in 78 countries) ~2,000,000 CPU core hours (>200 years)

Quantum Modeling

Quantum mechanically energy is quantized



$$H_{S} = \sum_{l=0}^{M-1} E_{l} |l\rangle \langle l| + \sum_{n,m=0}^{M/2-1} K_{2n,2m+1} (|2n\rangle \langle 2m+1| + |2m+1\rangle \langle 2n|)$$

Qubit Model: Keep lowest 2 energy levels

Qudit Model: Keep lowest d energy levels



Qubit Representation of Qudits

$$\epsilon = E_1 - E_0 = E_3 - E_2,
\omega_p = E_2 - E_0 = E_3 - E_1,
\Delta = 2K_{01},
\kappa_{xz} = K_{23} - K_{01} \approx K_{23},
\kappa_{xx} = 2K_{03} = 2K_{12}.$$



$$H_{eff} = \frac{1}{2} (\epsilon \sigma_z + \Delta \sigma_x) + \frac{1}{2} [\omega_p \tau_z + \kappa_{xz} \sigma_x (1 + \tau_z) + \kappa_{xx} \sigma_x \tau_x]$$

$$/$$
XZ coupling XX coupling

Multi-Qubit System

Logical qubits



Multi-Qubit System



Couple to each qubit an ancilla qubit with XX+XZ coupling

Multi-Qubit System

Coupled system Hamiltonian:

$$H_{S} = \frac{\Delta(t)}{2} \sum_{i=1}^{N} \sigma_{x}^{(i)} + E(t) \left[\sum_{i=1}^{N} h_{i} \sigma_{z}^{(i)} + \sum_{i,j=1}^{N} J_{ij} \sigma_{z}^{(i)} \sigma_{z}^{(j)} \right]$$
Original qubit
Hamiltonian
$$+ \frac{1}{2} \sum_{i=1}^{N} \left[\omega_{p}^{(i)}(t) \tau_{z}^{(i)} + \kappa_{xz}^{(i)}(t) \sigma_{x}^{(i)}(1 + \tau_{z}^{(i)}) + \kappa_{xx}^{(i)}(t) \sigma_{x}^{(i)} \tau_{x}^{(i)} \right]$$

Interaction Hamiltonian:

$$H_{\text{int}} = -\frac{1}{2} \sum_{i=1}^{N} (\sigma_z^{(i)} + \lambda \tau_x^{(i)}) Q_i$$

All parameters are directly extracted from the rf-SQUID Hamiltonian

The final ground state is unaffected by ancilla qubits

Experiment vs. Simulations



Classical and quantum simulations agree with experiment with no free parameters

Collaborators:

Experiment:

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